Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/827,285	CHEN ET AL.	
Examiner	Art Unit	

3745

Devin Hanan

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Class	Subclass	Date	Examiner
415	185		
	186R		
	189		
	178		
	234	9/17/2005	DH
updated	above	2/6/2006	DH
			1

INI	ITERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
consulted Ninh Nguyen on class 415 and 416	9/16/05	DH		